## YOKE ${ }^{\circledR}$

## APPROVAL SHEET

$\qquad$
Qi Hardware Inc
Item ：AT26 Crystal
Spec．no ：AT2608－012000－F20－YYY－YQA
Freq ： 12.000 MHz

| Customer Approved | Checked By | Issued By |
| :---: | :---: | :---: |
|  | 䫾覀美] | 寈傊垥 |

## 友桂電子股份有限公司 YOKETAN CORPORATION <br> E－mail：yoketec＠ms14．hinet．net http：／／www．yoketant．com．tw

```
Taichung Factory : 28-2 , NAN 2ND Rd, T.E.P.Z, Taichung, Taiwan (42760 )
    Tel: 886-4-25333353 Fax: 886-4-25338675
    Taipei Office : 9F-3 , No.107, Sec. 1,Zhongshan Rd., Xinzhuang City , Taipei, Taiwan (24250)
    Tel: 886-2-85227548 Fax: 886-2-85227546
    China Factory : Block C-3F,Da Zhou lnd. Estate , North Zhan Gang Rd, Zhaoqing City,Guangdong Province , P.R.C. (526020)
                        Tel: 86-758-6152666 Fax: 86-758-6152699
Shenzhen Office : Unit 1018,10/F., Hua Tong Building, Sungang Rd, Luohu District , Shenzhen City , P.R.C. (518008)
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    Wuxi Office : Block C-3F,Da Zhou Ind. Estate, North Zhan Gang Rd, Zhaoqing City, Guangdong Province, P.R.C. (214101)
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| Rev | Revise page | Revise Contents | Date | Ref.No. | Reviser |
| :---: | :---: | :---: | :---: | :---: | :---: |
| A | N/A | INITIAL ISSUE | $2008 / 4 / 3$ | N/A | Peggy Pen |
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## SPECIFICATION OF CRYSTAL UNITS

## Customer : Qi

## SPEC NO : AT2608-012000-F20-YYY-YQA <br> DATE : 4-Sep-09

## SPECIFICATION OF CRYSTAL UNITS

| 1 | Nominal frequency | 12.000 MHz |
| :--- | :--- | :--- |
| 2 | Frequency tolerance | $\pm 30 \mathrm{ppm}$ at $25 \pm 2{ }^{\circ} \mathrm{C}$ |
| 3 | Temperature characteristics | $\pm 30 \mathrm{ppm}$ |
| 4 | Operating temperature | $-10 \sim+60{ }^{\circ} \mathrm{C}$ |
| 5 | Shunt capatance | 7.0 pF Max. |
| 6 | Equiverent series resistance | 60 ohms Max. |
| 7 | Load capacitance | 20 pF |
| 8 Drive level | 10 uW Max. |  |
| 9 | Insulation resistance | $500 \mathrm{M} \mathrm{ohms} / 100 \pm 15 \mathrm{VDC}$ |
| 10 Aging | $\pm 5 \mathrm{ppm} / \mathrm{Year}$ |  |
| 11 Marking | S12000 |  |
| 12 Holder | As below |  |



## Note:

1.Heating up the package must be less than 150 degrees $/ 5 \mathrm{sec}$.
2.The crystal characteristics may be affected and destroyed at worst by bending the crystal.
3.The crystal characteristics may be affected and destroyed at worst by additional production process as ultrasonic welding or molding encapsulation. Please be sure to check if this process affects any damage to crystal products prior to use.

Reliability Test (applicable to 49(50) type .U type and Tuning Fork X'tal)

| Test Items | Test Condition | Specification |  |
| :---: | :---: | :---: | :---: |
|  |  | Dip | SMD |
| 1. Gross Leak Test | FC-40 $125^{\circ} \mathrm{C} / 30 \mathrm{sec}$ | No continuous bubble |  |
| $\begin{aligned} & \text { 2. Fine Leak } \\ & \text { Test } \end{aligned}$ | Bombing of $\mathrm{He} 4 \mathrm{~kg} / \mathrm{cm}^{2}$ for 2 hours | Less than $5^{*} 10^{\wedge}$-8atm.c.c./sec, Helium |  |
| 3. Drop Test | ar $\sim 19.999 \mathrm{MHz}$ (Fund.) $\rightarrow 100 \mathrm{~cm}$ height b. 20~29.999MHz(Fund.) $\rightarrow 50 \mathrm{~cm}$ height c. $30 \sim \quad \mathrm{MHz}$ (Fund.) $\rightarrow 20 \mathrm{~cm}$ height on hard wooden surface $/ 3$ times $\quad$ (thickness more than 30 mm ) | $\triangle \mathrm{F} \leqq \pm 10 \mathrm{PPM}$, C.I within spec. | $\triangle \mathrm{F} \leqq \pm 10 \mathrm{PPM}$, C.I within spec. |
| 4. Vibration Test | Freq. range: $10 \sim 55 \mathrm{~Hz}$ <br> Peak to peak amplitude: 1.5 mm 3 direction(X,Y,Z), each 60min. | $\triangle \mathrm{F} \leqq \pm 10 \mathrm{PPM}$, C.I within spec. | $\triangle \mathrm{F} \leqq \pm 10 \mathrm{PPM}$, C.I within spec. |
| $\begin{gathered} \text { 5. Resistance to } \\ \text { Soldering Test } \end{gathered}$ | a. IR Reflow furnace with the condition 2 times. Peak temp. $260 \pm 3^{\circ} \mathrm{C}, 10 \pm 1 \mathrm{sec}$. | NA | $\triangle \mathrm{F} \leqq \pm 10 \mathrm{PPM}$, <br> C.I within spec. <br> For SMD type only. |
|  | b. Dip terminals in a $245 \pm 5^{\circ} \mathrm{C}$ solder station(pool) Dipping depth $0.5 \mathrm{~mm}($ Min $)$ Dipping time $5 \pm 0.5 \mathrm{sec}$. | At least $90 \%$ by 30X magnification of each dipped area shall be covered by fresh solder. For DIP type only. | NA |
| 6. Bending Test | Bending cycle : 1 cycle $0^{\circ}->45^{\circ}->0^{\circ}->45^{\circ}->0^{\circ}$ | $\triangle \mathrm{F} \leqq \pm 5 \mathrm{PPM}$ <br> C.I within spec. <br> For DIP type only. | NA |
| 7. Shearing Test | Weight : 5 N, Test duration : $10 \pm 1 \mathrm{sec}$ | NA | $\triangle \mathrm{F} \leqq \pm 10 \mathrm{PPM}$, <br> C.I within spec. <br> For SMD type only. |
| $\begin{array}{\|c\|} \hline \text { 8. Low Temp. } \\ \text { Exposure Test } \end{array}$ | $-40 \pm 3^{\circ} \mathrm{C}, 240 \pm 12 \mathrm{hrs}$ | $\begin{aligned} & \triangle \mathrm{F} \leq \pm 10 \mathrm{PPM} \\ & \text { C.I within spec. } \end{aligned}$ | $\begin{aligned} & \triangle \mathrm{F} \leqq \pm 10 \mathrm{PPM} \\ & \text { C.I within spec. } \end{aligned}$ |
| 9. Aging Test | $85 \pm 3^{\circ} \mathrm{C}, 240 \pm 12 \mathrm{hrs}$ | $\begin{aligned} & \triangle \mathrm{F} \leq \pm 10 \mathrm{PPM} \\ & \text { C.I within spec. } \end{aligned}$ | $\begin{aligned} & \triangle \mathrm{F} \leqq \pm 10 \mathrm{PPM} \\ & \text { C.I within spec. } \end{aligned}$ |
| 10. High Temp. \& Humidity Test | $+85^{\circ} \mathrm{C} \pm 5^{\circ} \mathrm{C} \& 85 \% \pm 5 \%$ R.H. , $240 \pm 12 \mathrm{hrs}$ | $\begin{aligned} & \triangle \mathrm{F} \leq \pm 10 \mathrm{PPM} \\ & \text { C.I within spec. } \end{aligned}$ | $\begin{aligned} & \triangle \mathrm{F} \leq \pm 10 \mathrm{PPM} \\ & \text { C.I within spec. } \end{aligned}$ |
| 11. Temperature Cycling Test | $\begin{gathered} -25 \pm 3^{\circ} \mathrm{C} / 15 \pm 3 \mathrm{~min} \sim+85 \pm 3^{\circ} \mathrm{C} / 15 \pm 3 \mathrm{~min} \\ 15 \text { cycles } \\ \hline \end{gathered}$ | $\begin{gathered} \triangle \mathrm{F} \leqq \pm 10 \mathrm{PPM}, \\ \text { C.I within spec. } \end{gathered}$ | $\begin{aligned} & \triangle \mathrm{F} \leq \pm 10 \mathrm{PPM} \\ & \text { C.I within spec. } \end{aligned}$ |

## 測試報告 <br> Test Report

號碋（No．）：CE／2008／B0506 日期（Date）：2008／11／11 頁数（Page）： 1 of 8

友桂奄子股份有限公司

YOKETAN CORPORATION

28－2，NAN 2 ND ROAD，T．E．P．Z，TAICHUNG，TAIWAN
 identified by／on behalf of the client as）：

| 栐品名稱（Sample Description） |  | CYLINDER CRYSTAL UNITS |
| :---: | :---: | :---: |
| 栐品型䑛（Style／Item No．） |  | ATXX SERIES／XVR200 SERIES |
| 收件日期（Sample Receiving Date） |  | 2008／11／04 |
| 测試期間（Testing Period） |  | 2008／11／04 TO 2008／11／11 |

测㺂結果（Test Results）
：請見下一頁（Please refer to next pages）．

[^0]
## 测試報告

Test Report
友桂電子股份有限公司
YOKETAN CORPORATION

28－2，NAN 2ND ROAD，T．E．P．Z，TAICHUNG，TAIWAN

## 测袋姑果（Test Results）

测武部位（PART NAXE）NO．1 ：整體混测（共5款）（MIXED ALL PARTS（FIVE KINDS））

| 测試项目 （Test Items） | 單位 <br> （Unit） | 测亦方法 <br> （Method） | 方法僋测㮀限値 （MDL） | 結果 （Result） |
| :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | NO． 1 |
| 緺／Cadmium（Cd） | $\mathrm{mg} / \mathrm{kg}$ | 季考IEC 62321／2nd CDV（111／95／CDV）方法，用虑應萎合電祡原子發射光諳儀 （ICP－AES）检测錇含量．／With reference to IEC 62321／2nd CDV （111／95／CDV）．Determination of Cadmium by ICP－AES． | 2 | n．d． |
| 矩／Lead（ Pb ） | $\mathrm{mg} / \mathrm{kg}$ | 参考IEC 62321／2nd CDV（111／95／CDV） <br>  <br>  reference to IEC $62321 / 2 n d$ CDV （111／95／CDV）．Determination of Lead by ICP－AES． | 2 | n．d． |
| 采／Mercury（Hg） | $\mathrm{mg} / \mathrm{kg}$ | 条考IEC 62321／2nd CDV（111／95／CDV） <br>  （ICP－AES）检测泉含量．／With reference to IEC 62321／2nd CDV （111／95／CDV）．Determination of Mercury by ICP－AES． | 2 | n．d． |
| 六債愘／Hexavalent Chromium Cr（VI） by alkaline extraction | $\mathrm{mg} / \mathrm{kg}$ | 针期非金属材質之栐品，秀考IEC 62321／2nd CDV（111／95／CDV）方法检测，用UV－VIS殓测六供笿含量．／With reference to IEC 62321／2nd CDV （111／95／CDV）．Determination of Hexavalent Chromium for non－ metallic samples by UV－Vis Spectrometry． | 2 | n．d． |

[^1]
## 测試報告

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友桂電子股份有限公司

YOKETAN CORPORATION
台中槂滞子郎台中加工出口區南二路28號之 2
28－2，NAN 2 ND ROAD，T．E．P．Z，TAICHUNG，TAIWAN

| 测試項目 （Test Items） | 軍位 | 测武方法 （Method） | 方法僋测極限值 | $\begin{gathered} \text { 結果 } \\ \text { (Result) } \\ \hline \end{gathered}$ |
| :---: | :---: | :---: | :---: | :---: |
|  |  |  | （MDL） | NO． 1 |
| $\begin{aligned} & \text { 全氟辛炕磺酸 / Perfluorooctane } \\ & \text { sulfonates (PFOS) } \\ & \text { PFOS - Acid } \\ & \text { PFOS - Metal Salt } \\ & \text { PFOS - Amide } \end{aligned}$ | $\mathrm{mg} / \mathrm{kg}$ | 参考US EPA 3540C：1996方法，以液相層析質䛶儀检测全氟辛炕磺酸含量。 <br> With reference to US EPA 3540C： <br> 1996 method for PFOS Content． <br> Analysis was performed by LC／MS． | 10 | n．d． |
| 多澳碰苯镘和／Sum of PBBs | $\mathrm{mg} / \mathrm{kg}$ | 条考IEC 62321／2nd CDV（111／95／CDV） <br> 昲苹和多渗摔苯酸含量．／With reference to IBC 62321／2nc CDV （111／95／CDV）．Determination of PBB and PBDE by GC／MLS． | － | n．d． |
| 一涘㖒苯／Monobromobiphenyl |  |  | 5 | n．d． |
| 二涘㖒苯／Dibromobiphenyl |  |  | 5 | n．d． |
| 三涣譏苯／Tribromobiphenyl |  |  | 5 | n．d． |
| 四涣䎴苯／Tetrabromobiphenyl |  |  | 5 | n．d． |
| 五涘哖苯／Pentabromobipheny1 |  |  | 5 | n．d． |
| 六涣様苯／Hexabromobiphenyl |  |  | 5 | n．d． |
| 比滇侍苯／Heptabromobiphenyl |  |  | 5 | n．d． |
| 八涣聠苯／Octabromobiphenyl |  |  | 5 | n．${ }^{\text {d }}$ ． |
| 九涘㖒本／Nonabromobiphenyl |  |  | 5 | n．d． |
| 十涣哑苯／Decabromobiphenyl |  |  | 5 | n．d． |
| 多浣輯苯酵境和／Sum of PBDEs |  |  | － | E．d． |
| 一漫㒋苯酵／Monobromodiphenyl ethe： |  |  | 5 | n．d． |
| 二涣䋅苯醍／Dibromodiphenyl ether |  |  | 5 | n．d． |
| 三澳珗苯醇／Tribromodiphenyl ether |  |  | 5 | n．d． |
| 四涣犘苯酲／Tetrabromodiphenyl ether |  |  | 5 | n．d． |
| 五涣侎苯酝／Pentabromodiphenyl ether |  |  | 5 | n．d． |
| 六涘㙂苯醚／Hexabromodiphenyl ether |  |  | 5 | n．d． |
| 七渗聨苯酳／Heptabromodiphenyl ether |  |  | 5 | n．d． |
| 入滇件苯酝／Octabromodiphenyl ether |  |  | 5 | n．d． |
| 九涣帏苯醇／Nonabromodiphenyl ether |  |  | 5 | n．d． |
| 十渔䏇苯酝／Decabromodiphenyl ether |  |  | 5 | n．©． |

[^2]
## 測試報告 <br> Test Report

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友桂電子股份有限公司
｜ำ｜ํ｜｜ YOKETAN CORPORATION

$28-2$ ，NAN $2 N D$ ROAD，T．E．P．Z，TAICHUNG，TAIWAN

## 備註（Note）：

1． $\mathrm{mg} / \mathrm{kg}=\mathrm{ppm}$
2．n．d．$=$ Not Detected（未检出）
3．MDL $=$ Method Detection Limit（方法㑯测極限值）
4．$"-"=$ Not Regulated（無规格值）
5．樣品的测試是基於申請人要求混合测試，報告中的混合测試结果不代表其中佃别赀一材質的含量．
（The samples was／were analyzed on behalf of the applicant as mixing sample in one testing． The above results was／were only given as the informality value．）

PFOS条考责訊（Reference Information）：指令 $2006 / 122 / \mathrm{EC}$（Directive 2006／122／EC）
（1）該物質不可置於市場上或使用於特殊物質或配置成分重量婊度等於或大於 $0.005 \%$ 。
（May not be placed on the market or used as a substance or constituent of preparations in a concentration equal to or higher than $0.005 \%$ by mass．）
（2）该物質不可置於市場上的半成品或商品或其物件；候若零件上明顕地具有PFOS掽参照結橉上及微细構造上計算

（Nay not be placed on the market in semi－finished products or articles，or parts thereof，if the concentration of PFOS is equal to or higher than $0.1 \%$ by mass calculated with reference to the mass of structurally or microstructurally distinct parts that contain PFOS or，for textiles or other coated materials，if the amount of PFOS is equal to or higher than $1 \mu \mathrm{~g} / \mathrm{m}^{2}$ of the coated material．）

## 測試報告

## Test Report

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友桂電子股份有限公司

YOKETAN CORPORATION
台中縣潭子鄉台中加工出口區南二路 28 躆之 2
$28-2$ ，NAN 2ND ROAD，T．E．P．Z，TAICHUNG，TAIWAN

1）根據以下的流程図之條件，粶品已完全源解。（六備䂏测试方法除外）／These samples were dissolved totaliy by pre－conditioning method according to below flow chart．（ $\mathrm{Cr}^{6+}$ test method excluded）
2）测試人员：㰾登倩／Name of the person who made measurement：Climbgreat Yang
3）测武負責人：张啓興／Name of the person in charge of measurement：Troy Chang


[^3]
## 測試報告 <br> Test Report

友桂電子股份有限公司

## 全氟辛酸（铵）／全氟辛烷磺酸分析流程圆／ <br> Analytical flow chart of PFOA／PFOS content

1）测武人員：㓡家瑗／Name of the person who made measurement：Carrie Liu
2）测試負责人：陳新智／Name of the person in charge of measurement：Shinjyh Chen


## 測試報告 Test Report

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友桂電子股份有限公司

YOKETAN CORPORATION
台中㗭湋子嫏台中加工出口區南二路28躆之2
28－2，NAN 2ND ROAD，T．E．P．Z．TAICHUNG，TAIWAN

## 多溴聯苯／多澳聯苯醚分析流程圆／PBB／PBDE analytical FLOW CHART

1）测試人員：給形彬／Name of the person who made measurement：Roman Wong
2）测試負责人：陳新替／Name of the person in charge of measurement：Shinjyh Chen
初次测武程序／First testing process
選择性飾检程序／Optional screen proces
確認程序／Confirmation process－－－


[^4]
## 測試報告

Test Report
友桂電子股份有限公司
YOKETAN CORPORATION
台中畭㵏子榔台中加工出口區南二路28號之2
$28-2$ ，NAN 2 ND ROAD，T．E．P．Z，TAICHUNG，TAIWAN


[^5]
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